

Notice of References Cited	Application/Control No. 10/634,845		Applicant(s)/Patent Under Reexamination MURAYAMA ET AL.	
	Examiner JEFFREY G. HOEKSTRA		Art Unit 3736	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,193,706 B1	02-2001	Thorud et al.	604/533
*	B	US-2001/0009980 A1	07-2001	RICHARDSON et al.	600/585
*	C	US-2001/0011158 A1	08-2001	Howland, Johathan M.	600/585
*	D	US-2002/0032390 A1	03-2002	Jafari, Mo	600/585
*	E	US-6,402,706 B2	06-2002	Richardson et al.	600/585
*	F	US-2002/0087099 A1	07-2002	Nanis et al.	600/585
*	G	US-6,544,197 B2	04-2003	DeMello, Richard M.	600/585
*	H	US-2003/0125641 A1	07-2003	Jafari et al.	600/585
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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